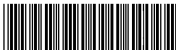


Search Notes**Application/Control No.**

10/759,642

**Applicant(s)/Patent under
Reexamination**

ERIC YEH ET AL.

Examiner

PIERRE-LOUIS DESIR

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	466	4/16/2009	PD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	4/16/2009	PD